

Search Notes

Application/Control No.

10/617,259

Examiner

German Viana Di Prisco

Applicant(s)/Patent under
Reexamination

NA ET AL.

Art Unit

2609

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Image and keyword search in USPAT, US-PGPUB, DERWENT,EPO,JPO and IBM_TDB (see attached search strategy)	2/16/2007	GVDP
Inventor name and Assignee search in PALM ExPO and EAST	2/16/2007	GVDP
EPO Database(http://ep.espacenet.com)	2/16/2007	GVDP
EPO Database(http://ep.espacenet.com)	2/16/2007	GVDP
KIPO Database (http://www.kipo.go.kr)	2/16/2007	GVDP
Consulted with Rafael Perez-Gutierrez	2/16/2007	GVDP